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	Application No.	Applicant(s)
Notice of Allowability	10/709,603	CHUANG ET AL.
	Examiner	Art Unit
	David Nhu	2818
The MAILING DATE of this communication apperature All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIOF of the Office or upon petition by the applicant. See 37 CFR 1.313	ears on the cover sheet with the of (OR REMAINS) CLOSED in this appropriate communication (GHTS). This application is subject	correspondence address pplication. If not included on will be mailed in due course. THIS
1. This communication is responsive to 6/1/06.		
2. The allowed claim(s) is/are <u>1-16</u> .		
3. ☑ Acknowledgment is made of a claim for foreign priority ur a) ☑ All b) ☐ Some* c) ☐ None of the: 1. ☑ Certified copies of the priority documents have 2. ☐ Certified copies of the priority documents have 3. ☐ Copies of the certified copies of the priority do	been received. been received in Application No.	
International Bureau (PCT Rule 17.2(a)). * Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application. THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		
4. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give		
5. CORRECTED DRAWINGS (as "replacement sheets") mus	st be submitted.	
(a) 🔲 including changes required by the Notice of Draftspers	son's Patent Drawing Review(PTC	0-948) attached
1) 🗌 hereto or 2) 🔲 to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1		
each sheet. Replacement sheet(s) should be labeled as such in t		
6. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.		
Attachment(s)	F Notice of Informal	Potent Application (PTO 152)
 Notice of References Cited (PTO-892) Notice of Draftperson's Patent Drawing Review (PTO-948) 	6. ☐ Interview Summar	Patent Application (PTO-152) v (PTO-413).
	Paper No./Mail D	ate
 Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 	08), 7. 🗌 Examiner's Amend	amenvComment
4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. ⊠ Examiner's Staten 9. □ Other	nent of Reasons for Allowance
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REASONS FOR ALLOWANCE

1. Claims 1-16 are allowed.

- 2. The following is an examiner's statement of reasons for allowance: None of the references of record teaches or suggests as cited in claims 1, 9: A method of increasing a cell retention of a silicon nitride read-only-memory, wherein the silicon nitride read-only-memory is formed inside a wafer, comprising: performing a plasma treatment to the wafer, wherein the plasma treatment is last plasma treatment of the wafer; baking the wafer; and performing a wafer sort test (as cited in claim 1); forming a passivation layer and a patterned photoresist layer over the wafer; etching away a portion of the passivation layer using the patterned photoresist layer as a mask; removing the patterned photoresist layer; performing an after etch inspection; performing an alloying process; performing a wafer acceptance test; performing a quality control inspection; performing a wafer sort gest; wherin one major aspect of the method is to perform the baking process after removing the patterned photoresist layer but before the wafer sort test (as cited in claim 9).
- 3. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

CONCLUSION

4. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure: Liu et al (6,869,844 B1): Method and Structure for Protecting NROM Device from Induced Charge Damage during Device Fabrication.

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5. Any inquiry concerning this communication on earlier communications from the examiner should be directed to David Nhu, (571)272-1792. The examiner can normally be reached on Monday-Friday from 7:30 AM to 5:00 PM.

The fax phone number for the organization where this application or proceeding is assigned is (571)273-8300.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

David Nhu

June 29, 2006

DAVID NHU PRIMARY EXAMPLE